STF7LN80K5



N-channel 800 V, 0.95 Ω typ., 5 A MDmesh™ K5 Power MOSFET in a TO-220FP package

Datasheet - production data

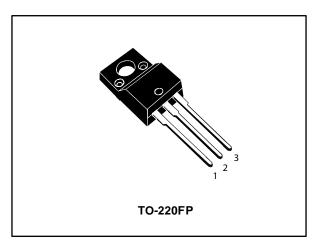
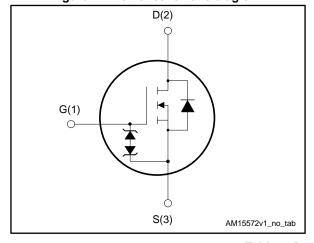


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	Ι _D
STF7LN80K5	800 V	1.15 Ω	5 A

- Industry's lowest R_{DS(on)} x area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STF7LN80K5	7LN80K5	TO-220FP	Tube

Contents STF7LN80K5

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STF7LN80K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	± 30	V
$I_D^{(1)}$	Drain current (continuous) at T _C = 25 °C	5	Α
$I_{D}^{(1)}$	Drain current (continuous) at T _C = 100 °C	3.4	Α
I _D ⁽²⁾	Drain current (pulsed)	20	Α
P _{TOT}	Total dissipation at $T_C = 25$ °C	25	W
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; $T_{\rm C}$ =25 °C)	2500	V
dv/dt (3)	Peak diode recovery voltage slope	4.5	\ //
dv/dt (4)	MOSFET dv/dt ruggedness	50	V/ns
T _{stg}	Storage temperature range	55 to 150	°C
T_J	Operating junction temperature range	- 55 to 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	5	°C/W
$R_{thj\text{-}amb}$	Thermal resistance junction-ambient	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	1.5	Α
E _{AS}	Single pulse avalanche energy (starting Tj = 25 °C, I_D = I_{AR} , V_{DD} = 50 V)	200	mJ

⁽¹⁾Limited by maximum junction temperature

⁽²⁾Pulse width limited by safe operating area

 $^{^{(3)}}I_{SD} \le 5$ A, di/dt 100 A/µs; V_{DS} peak < V_{(BR)DSS,}V_{DD}= 640 V

 $^{^{(4)}}V_{DS} \le 640 \text{ V}$

Electrical characteristics STF7LN80K5

2 Electrical characteristics

 T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ mA}$	800			V
		$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$ $T_{C} = 125 ^{\circ}\text{C}$			50	μΑ
I _{GSS}	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	4	5	>
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$		0.95	1.15	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		ı	270	1	pF
C _{oss}	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$	ı	22	ı	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0 V	1	0.5	ı	pF
C _{o(er)} ⁽¹⁾	Equivalent capacitance energy related	V _{DS} = 0 to 640 V, V _{GS} = 0 V	-	17	-	nC
C _{o(tr)} ⁽²⁾	Equivalent capacitance time related	V _{DS} = 0 to 640 V, V _{GS} = 0 V	1	48		nC
R_g	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D=0 \text{ A}$	-	7.5	-	Ω
Q_g	Total gate charge	$V_{DD} = 640 \text{ V}, I_D = 5 \text{ A}$	-	12	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	2.6	-	nC
Q_{gd}	Gate-drain charge	See (Figure 15: "Test circuit for gate charge behavior")	-	8.6	-	nC

Notes:

Table 7: Switching times

Table 1. Owiterining times							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	V_{DD} = 400 V, I_{D} =2.5 A, R_{G} = 4.7 Ω	1	9.3	1	ns	
t _r	Rise time	V _{GS} = 10 V	ı	6.7	1	ns	
t _{d(off)}	Turn-off delay time	See (Figure 14: "Test circuit for resistive load switching times" and	ı	23.6	ı	ns	
t _f	Fall time	Figure 19: "Switching time waveform")	-	17.4	-	ns	

 $^{^{(1)}}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

 $^{^{(2)}}$ Time related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		5	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		20	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 5 \text{ A}, V_{GS} = 0 \text{ V}$	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/μs,V _{DD} = 60 V See Figure 16: "Test circuit for inductive load switching and diode recovery times"	-	276		ns
Q _{rr}	Reverse recovery charge		-	2.13		μC
I _{RRM}	Reverse recovery current		ı	15.4		Α
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/μs V _{DD} = 60 V, T _j = 150 °C See Figure 16: "Test circuit for inductive load switching and diode recovery times"	-	402		ns
Qrr	Reverse recovery charge		-	2.79		μC
I _{RRM}	Reverse recovery current		-	13.9		Α

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	I_{GS} = ± 1mA, I_{D} = 0 A	30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

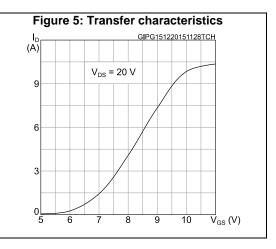
⁽¹⁾Pulse width limited by safe operating area

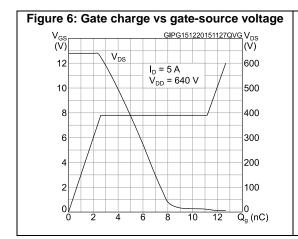
 $^{^{(2)}\}text{Pulsed:}$ pulse duration = 300 $\mu\text{s,}$ duty cycle 1.5%

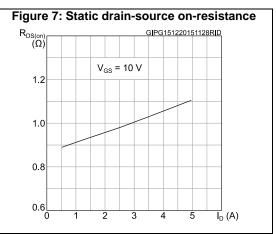
2.2 Electrical characteristics (curves)

Figure 2: Safe operating area $(A) \begin{tabular}{l} Operation in this area is limited by $R_{\tiny DS(m)}$ \\ \hline \end{tabular}$ 10¹ t ₅=10 µs 10⁰ t p=100 µs t p=1 ms t ₀=10 ms 10 T_i≤150 °C T_c= 25°C single pulse 10⁻² $\vec{V}_{DS}(V)$ 10⁰ 10¹ 10² 10³ 10

Figure 3: Thermal impedance K GC20940 δ = 0.5 δ = 0.05 δ = 0.02 δ = 0.01 Single pulse δ = 0.01 δ = 0.02 δ = 0.03 δ = 0.03 δ = 0.05 δ







STF7LN80K5 Electrical characteristics

Figure 8: Capacitance variations

C
(pF)

10³

10²

10¹

f = 1 MHz

Coss
CRSS

10⁻¹

10⁻¹

10⁻¹

10⁻¹

10⁰

10¹

10²

Vos (V)

Figure 10: Normalized V_{(BR)DSS} vs temperature

V_{(BR)DSS} (norm.)

1.12

I_D = 1 mA

1.08

1.04

1.00

0.96

0.92

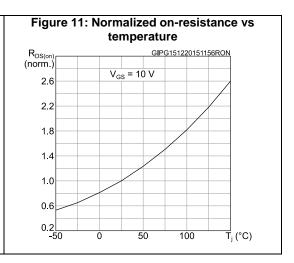
0.88

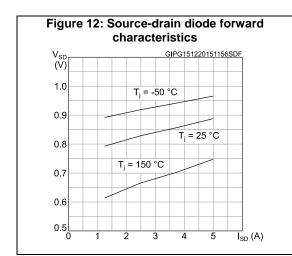
-50

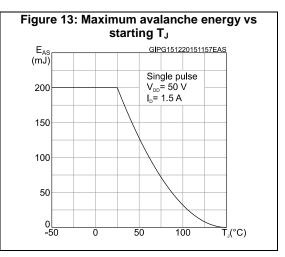
0 50

100

T_j (°C)







Test circuits STF7LN80K5

3 Test circuits

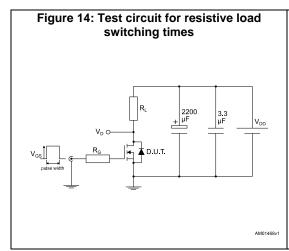


Figure 15: Test circuit for gate charge behavior

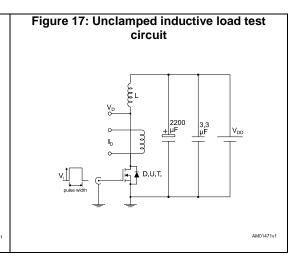
12 V 47 kΩ 100 nF 1 kΩ

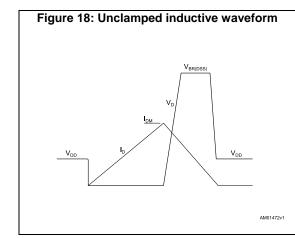
Vos 1 kΩ 1 kΩ

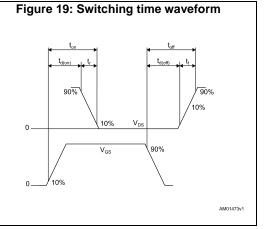
Vos 1 kΩ 1 kΩ

AM01469v1

Figure 16: Test circuit for inductive load switching and diode recovery times







4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of $\mathsf{ECOPACK}^{\otimes}$ packages, depending on their level of environmental compliance. $\mathsf{ECOPACK}^{\otimes}$ specifications, grade definitions and product status are available at: www.st.com. $\mathsf{ECOPACK}^{\otimes}$ is an ST trademark.

4.1 TO-220FP package information

Figure 20: TO-220FP package outline

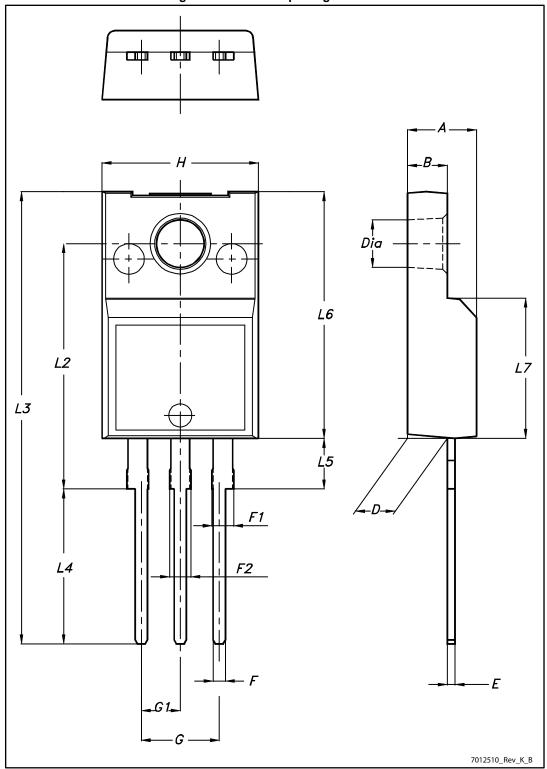


Table 10: TO-220FP package mechanical data

Dim	mm				
Dim.	Min.	Тур.	Max.		
A	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
Е	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
Н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		

Revision history STF7LN80K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
20-Jan-2016	1	First release.
25-Jan-2016	2	Updated: Figure 3: "Thermal impedance"
		Minor text changes

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